

Application/Control No.

Applicant(s)/Patent under  
Reexamination

09/736,051

KE ET AL.

Examiner

Art Unit

Patricia Leith

1655

**SEARCHED**

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

Class Subclass Date Examiner

DATE EXMR

514 211.02 7/18/2006 PL

updated

EAST:JPO,EPO,DERWENT,USPATF  
ULL,USPGPUBS,OCRBACKFILE

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PL

514 308,408 7/18/2006 PL

424 676,673 7/18/2006 PL

562 49,50 7/18/2006 PL

updated Inventor name search  
PALM/EAST

7/18/2006

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**INTERFERENCE SEARCHED**

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